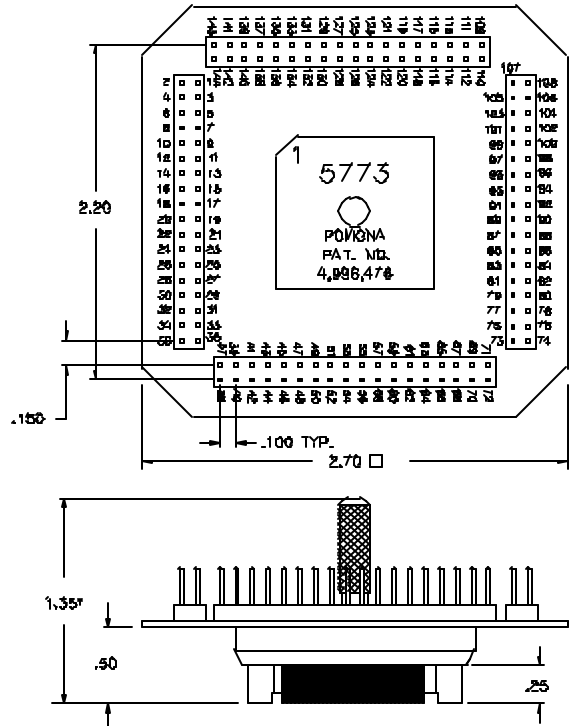
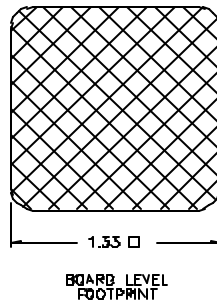
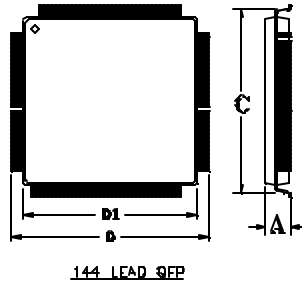


Model 5773 & 5773-2 144 Pin EIAJ QFP Test Clip 0.65mm Lead Pitch

These new test clips give the user an easy means to connect instrumentation to the fine pitch QFP chip leads.

- Interfaces with high density EIAJ QFP surface mount chip leads.
- Two stages of alignment assure positive connections.
- Gold plated connector pins and contacts assure noise free connections.
- Gold plated .025" square pins (or sockets) provide easy connection with either ribbon cable or discrete jumpers.



Pomona's EIAJ test clips are perfect for system designers, for field service testing, failure analysis, and for use with logic analyzers.

Other clips are also available in other sizes to fit the most popular EIAJ chips now in use. Pomona offers a test clip to fit the most commonly found variations of the EIAJ specifications.

Leads(mm) D	Body (mm) D1	Critical Dim(mm) C	Chip Height(mm) A	Pomona Part Number	Typical Applications
31.9	28.0	30.3	3.4 Max.	5773	AMD 29040
31.2	28.0	29.6	3.4 Max.	5773-2	SAB-C167

All dimensions are in inches. Tolerances (except noted): .xx = ±.02" (.51 mm), .xxx = ±.005" (.127 mm). All specifications are to the latest revisions. Specifications are subject to change without notice. Registered trademarks are the property of their respective companies. Made in USA